

Magnet diagnostic utilizing stray capacitance monitoring on a 2 m long CCT coil

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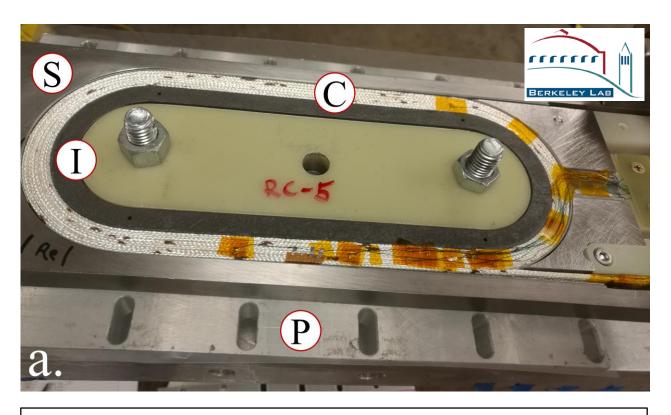
Utilizing stray capacitance change for quench detection

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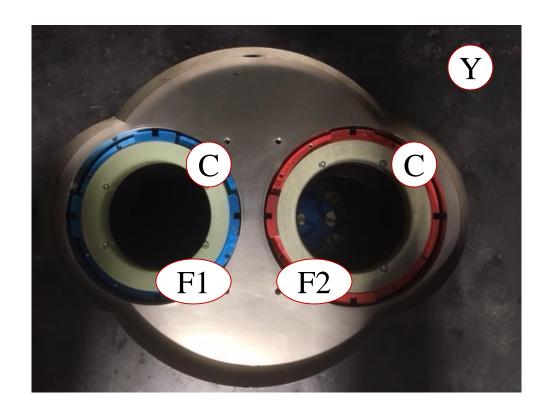


Stray capacitances in magnets...

Any metal component in the magnet structure that is electrically insulated from the others has a certain stray capacitance (capacitance to ground or between floating elements)



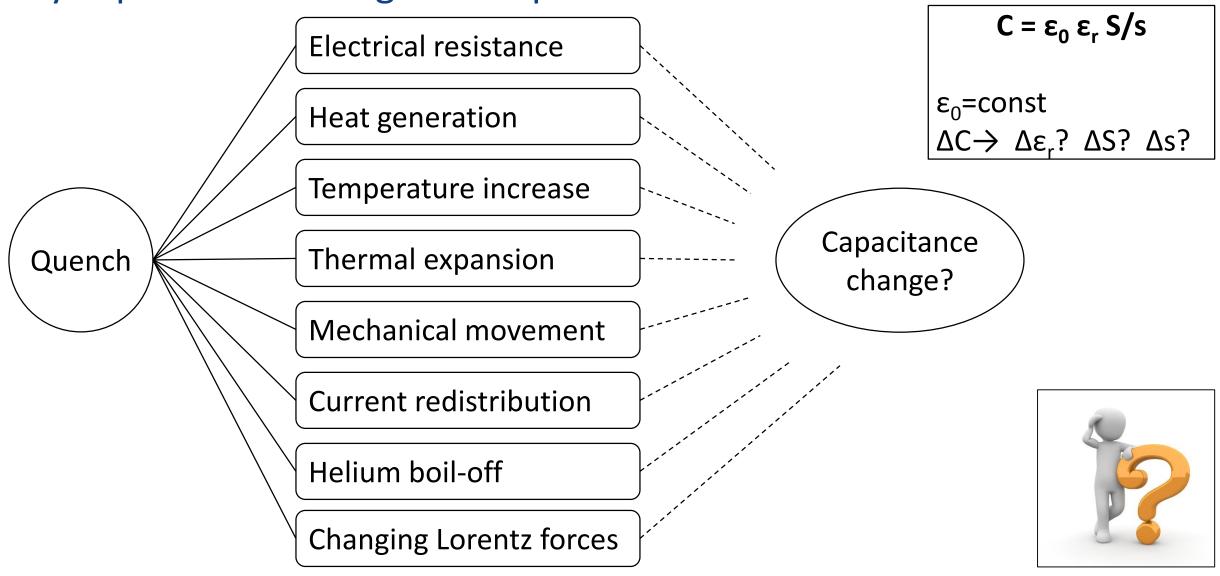
Example 1
Coil (C) – Pole island (I) – Horse shoe (S) – Plate (P)



Example 2
Coil (C) – 1st former (F1) – 2nd former (F2) – Yoke (Y)

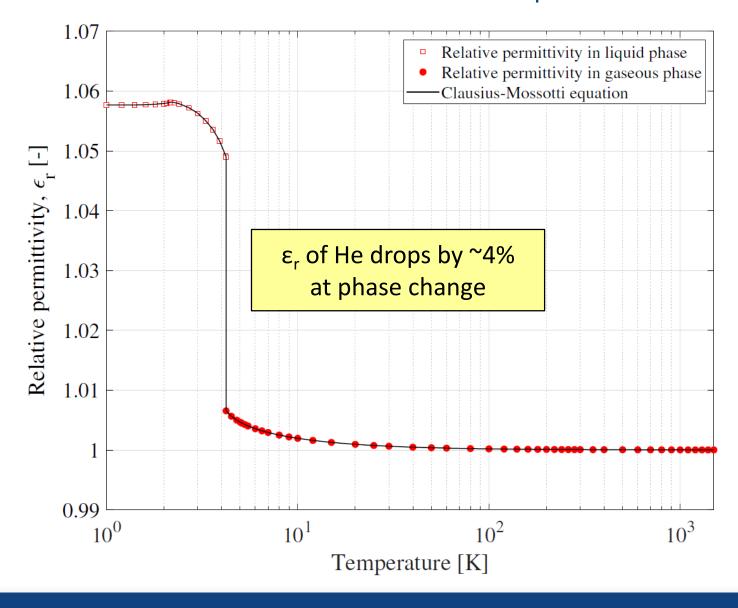


Stray capacitance change after quench





Drop of helium electrical permittivity ε_r at phase change

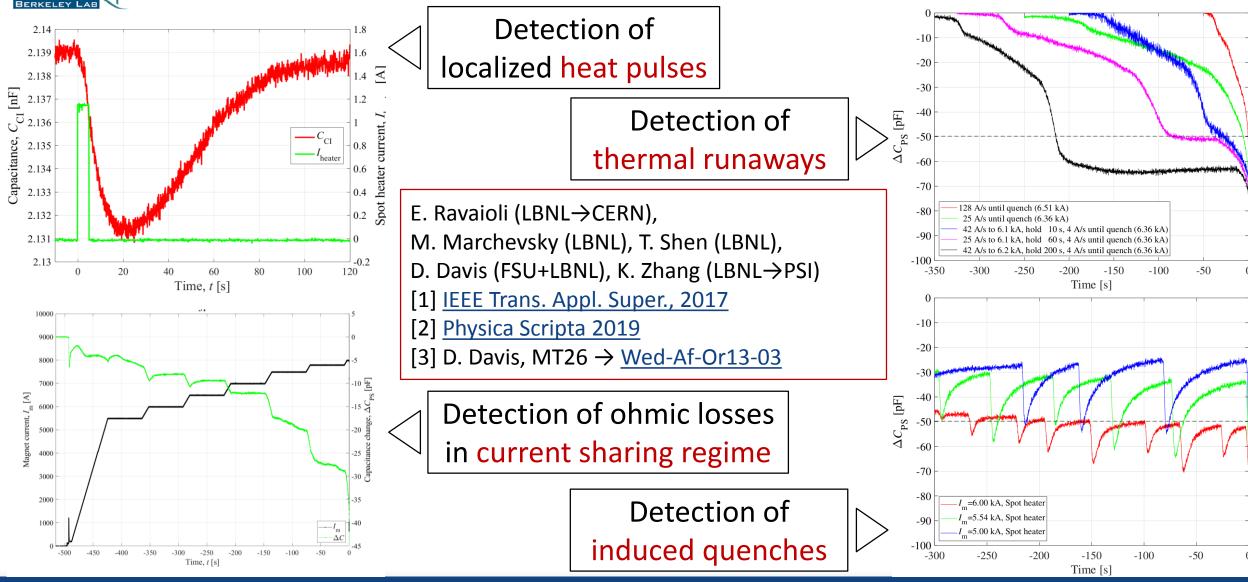


Local heating leads to a stray capacitance drop that can be detected





Utilizing stray capacitance change for quench detection [at LBNL]





2-aperture, 2 meter long, Nb-Ti CCT coil for HL-LHC

[at CERN]



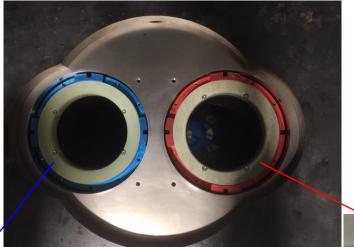


Quantity monitored:
Capacitance between
one coil former and ground
(iron yoke/coil/cryostat)



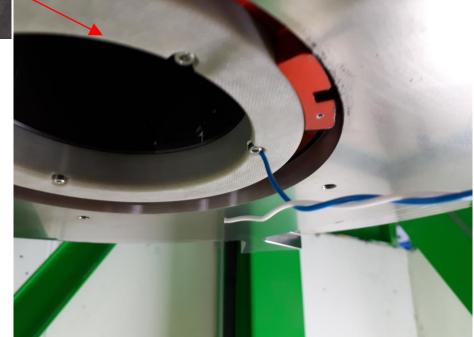


Taps connected to the two coil formers



Quantity monitored:
Capacitance between
one coil former and ground
(iron yoke/coil/cryostat)







Routing of the taps



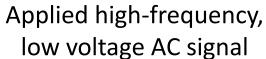




CERN capacitance monitoring system – HW

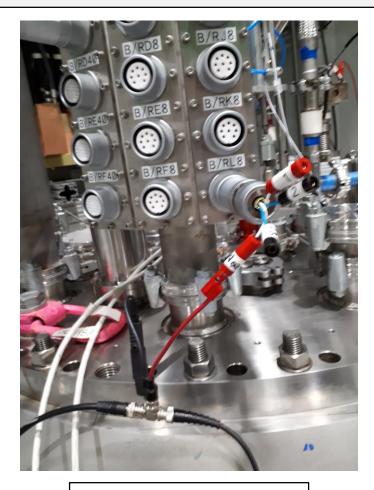
The system was designed and installed by K. Stachon and M. Bednarek (CERN).







Voltage and current measurement

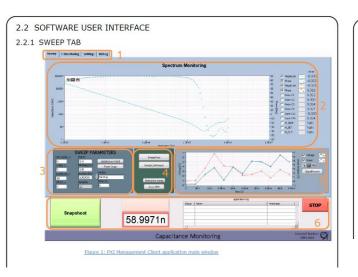


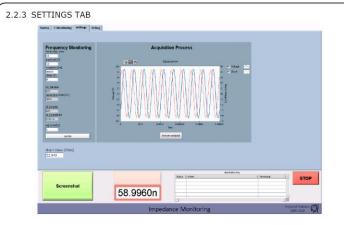
Voltage tap connection

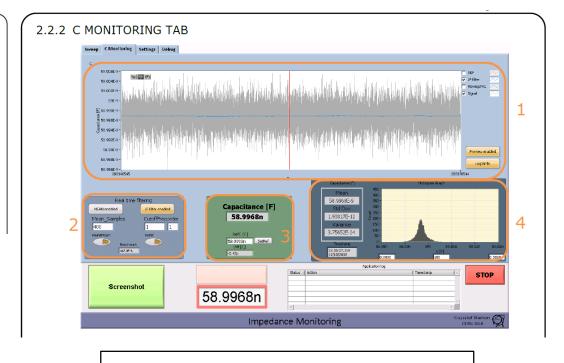


CERN capacitance monitoring system – SW

The system was designed and installed by K. Stachon and M. Bednarek (CERN).







Frequency transfer function

AC signal settings

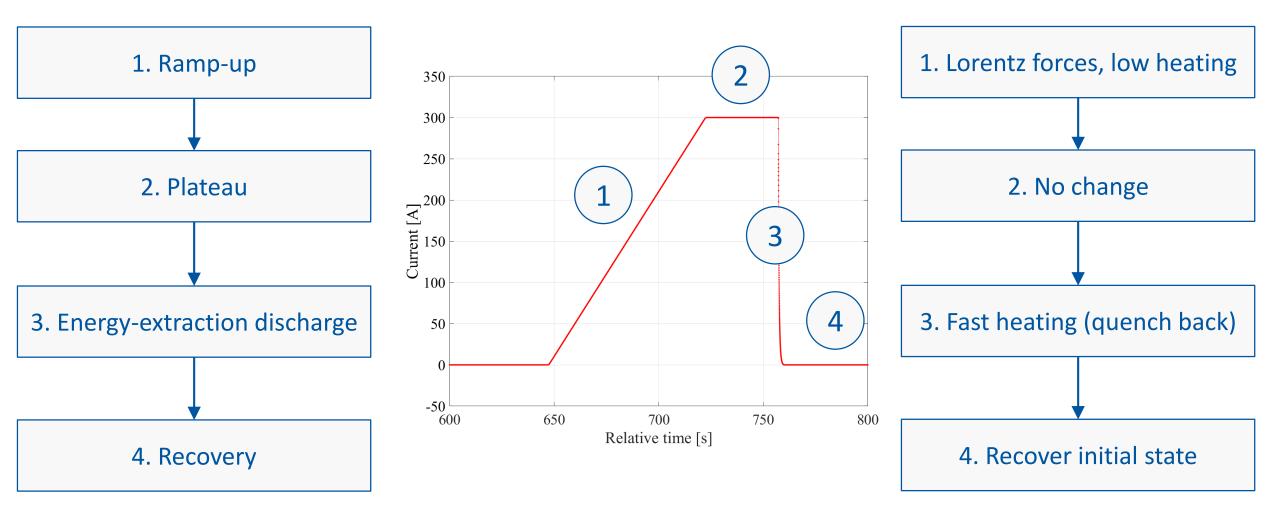
Online capacitance monitoring

When measuring a capacitance of tens of nF:

- → Noise <2 pF with acquisition frequency of 4 kHz
- → Noise <0.2 pF with acquisition frequency of 10 Hz

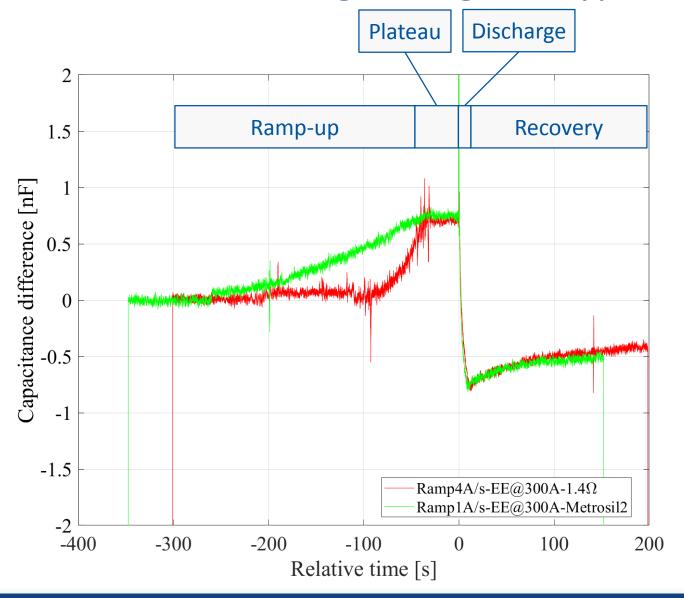


What we expect during an energy-extraction test





Capacitance monitoring during two typical tests



Ramp-up

Squeezing of insulation layer between coil and former $\rightarrow \Delta C$ increase [$C \approx \varepsilon_0 \varepsilon_r S/s$]

> <u>Plateau</u> No change

Discharge

Fast heating (quench back) and Lorentz forces disappear \rightarrow Fast $\triangle C$ decrease [$\mathbf{C} \approx \varepsilon_0 \ \varepsilon_r \ S/s$]

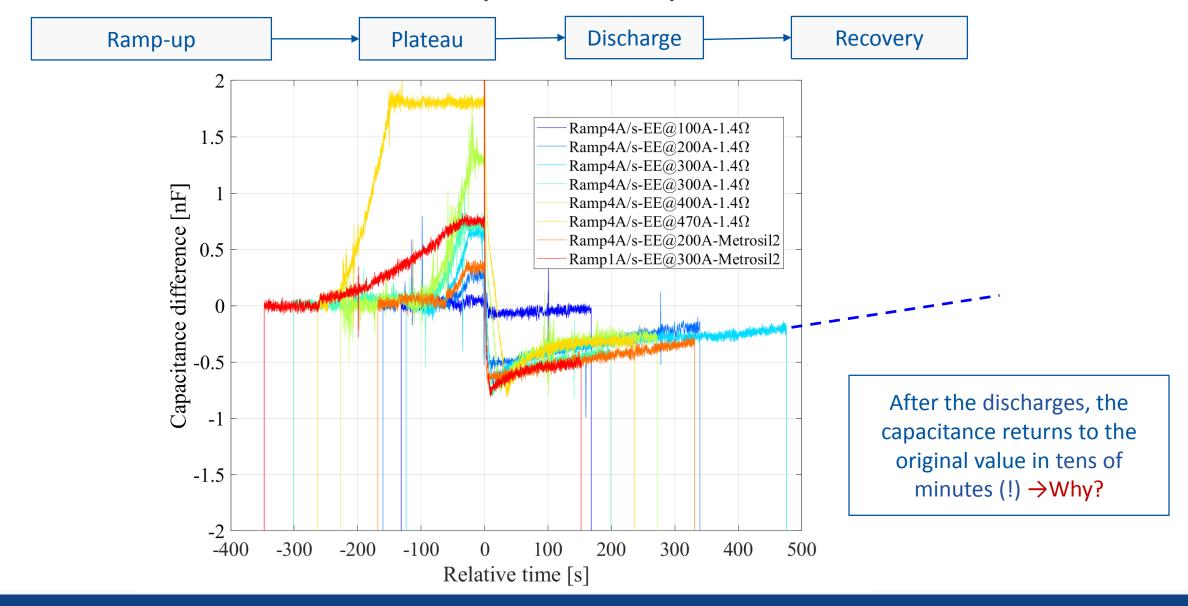
Recovery

Back to initial capacitance value $\Delta C \rightarrow 0$



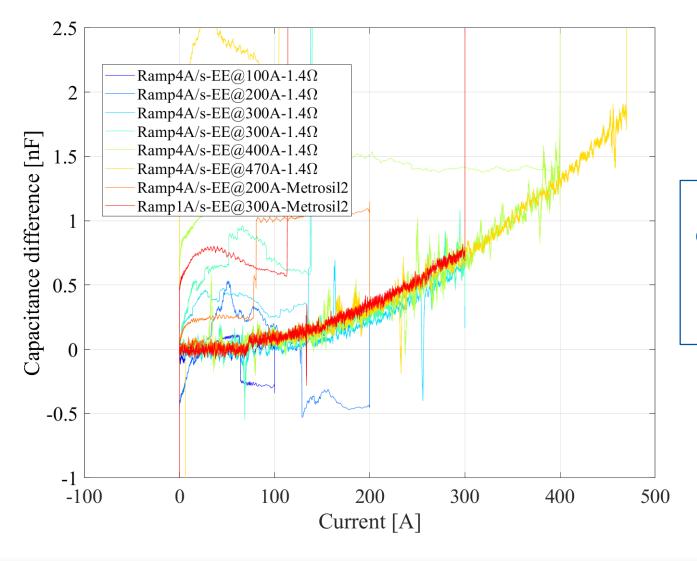
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Tests at different current levels (100-470 A)





Measured capacitance difference versus current



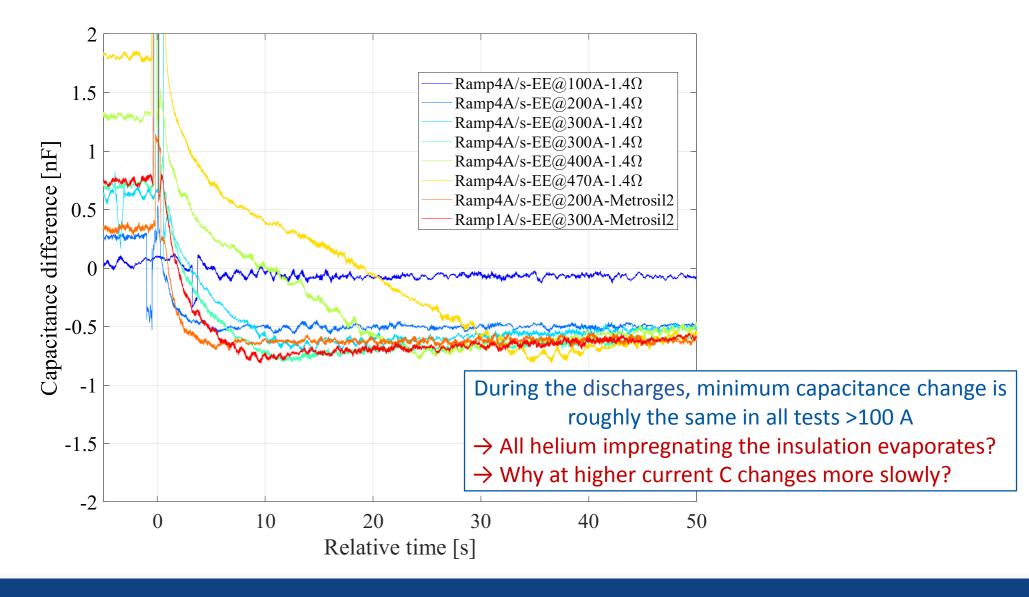
During the ramp-ups, capacitance change is roughly proportional to the square of the current

→ Lorentz force contribution



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Capacitance change during the discharge (zoom)





Conclusion

Stray capacitance change monitoring

- → Relatively **unobtrusive** technique that can be provide complementary diagnostic
- → Measurement system is **fast** enough, **precise** enough
- → [only in HTS coils] High heating was consistently detected hundred of ms or seconds before actual quench
- → **Different physical phenomena** were successfully observed/detected at LBNL and CERN
 - Change of phase and cryogenic conditions during warm-up
 - Transitory losses during ramp-ups ("AC losses")
 - Ohmic loss in the conductor in current-sharing regime
 - Ohmic loss in the conductor after quench (thermal runaway)
 - Ohmic loss in the splices
 - Heat deposited by external heaters
 - Lorentz forces during ramp-ups

Potential applications

- → Pre-quench heating **detection in HTS coils**Heating was consistently detected hundred of ms or seconds before actual quench
- → Information about magnet mechanical features

Capacitive strain gauges were used already decades ago

→ Information about **liquid He** level in the coil

→

The next step

Dedicated sensors with well-known size and features, purposefully built for one function

- → More sensitive to **one** physical phenomenon
- → Localization





QUESTIONS?

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Annex



Monitored powering tests

Ap1	Ap2	Ramp dI/dt [A/s]	I [A]	EE	Comments
Х		4	100	Resistor	
Х		4	200	Resistor	
Х		4	200	Metrosil	
Х		4	300	Resistor	
Х		4	300	Resistor	Repeated
Х		4	400	Resistor	
Х		4	470	Resistor	
Х		1	300	Metrosil	Slower ramp-up
Х		4	300	Metrosil	Different monitoring frequency
Х		4	300	Metrosil	Different monitoring voltage
	Х	4	200	Metrosil	No ΔC since Ap2 is not monitored
	Х	4	300	Metrosil	No ΔC since Ap2 is not monitored
	Х	4	350	Metrosil	No ΔC since Ap2 is not monitored
	Х	4	400	Metrosil	No ΔC since Ap2 is not monitored
Х	Х	4	400	Metrosil	Both apertures powered



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